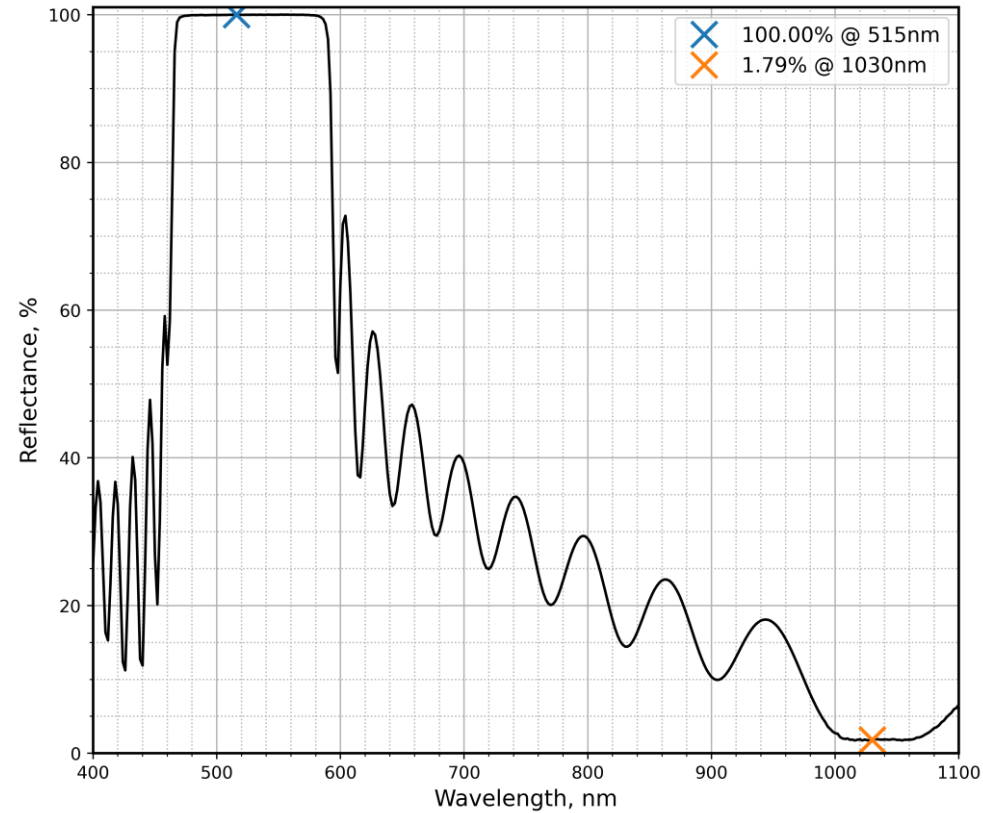


S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



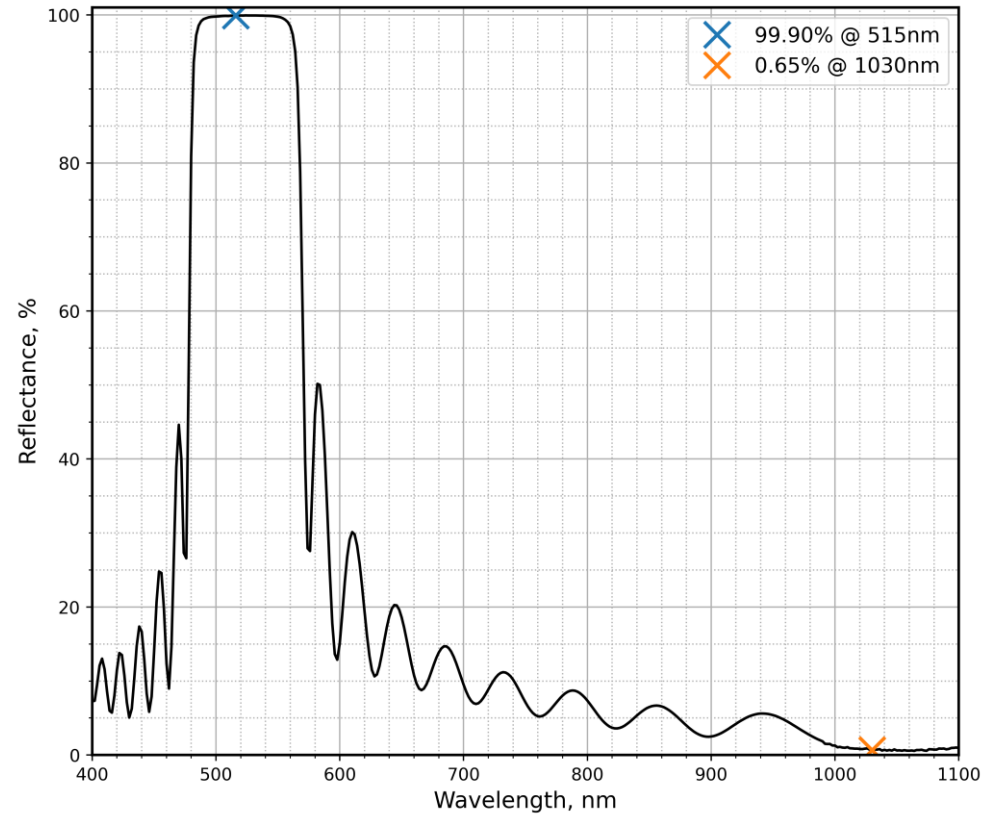
PO2870 Rs i45 (sample 1)

Fig. 1.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



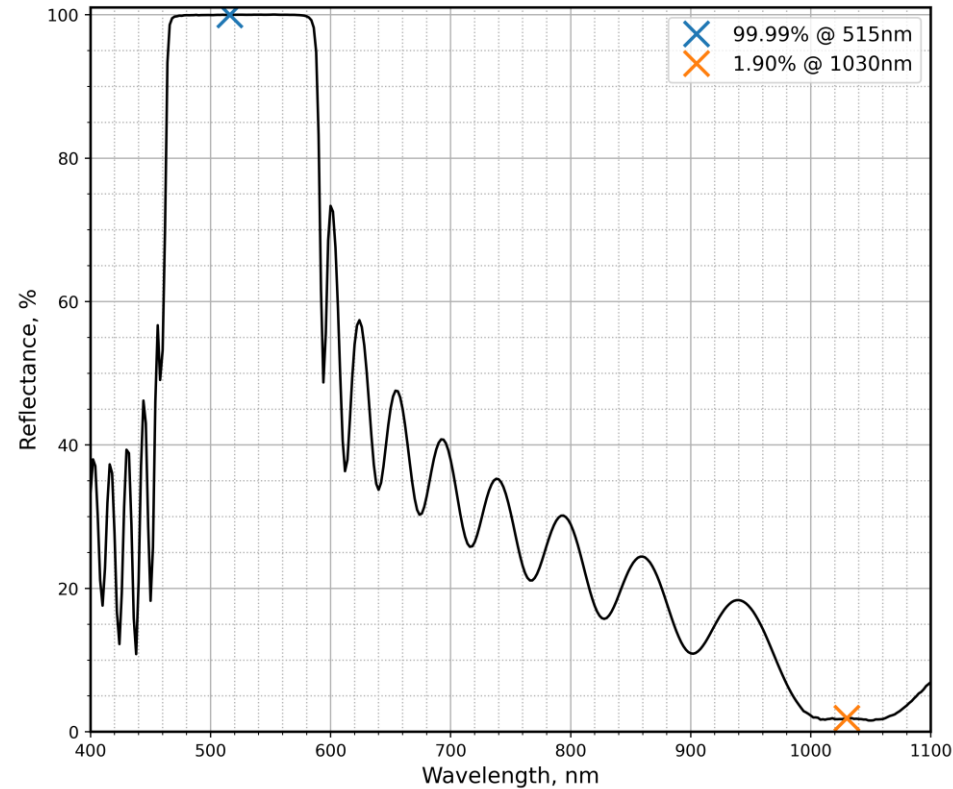
PO2870 Rp i45 (sample 1)

Fig. 2.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



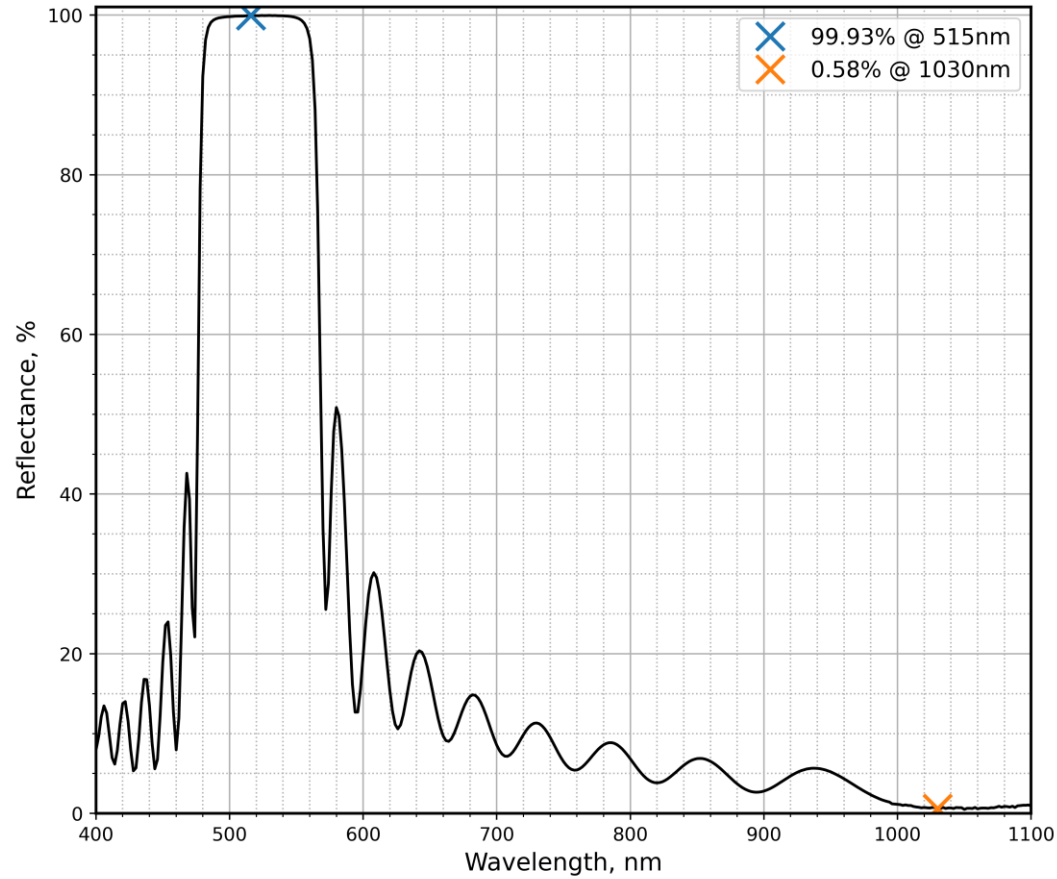
PO2870 Rs i45 (sample 2)

Fig. 3.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



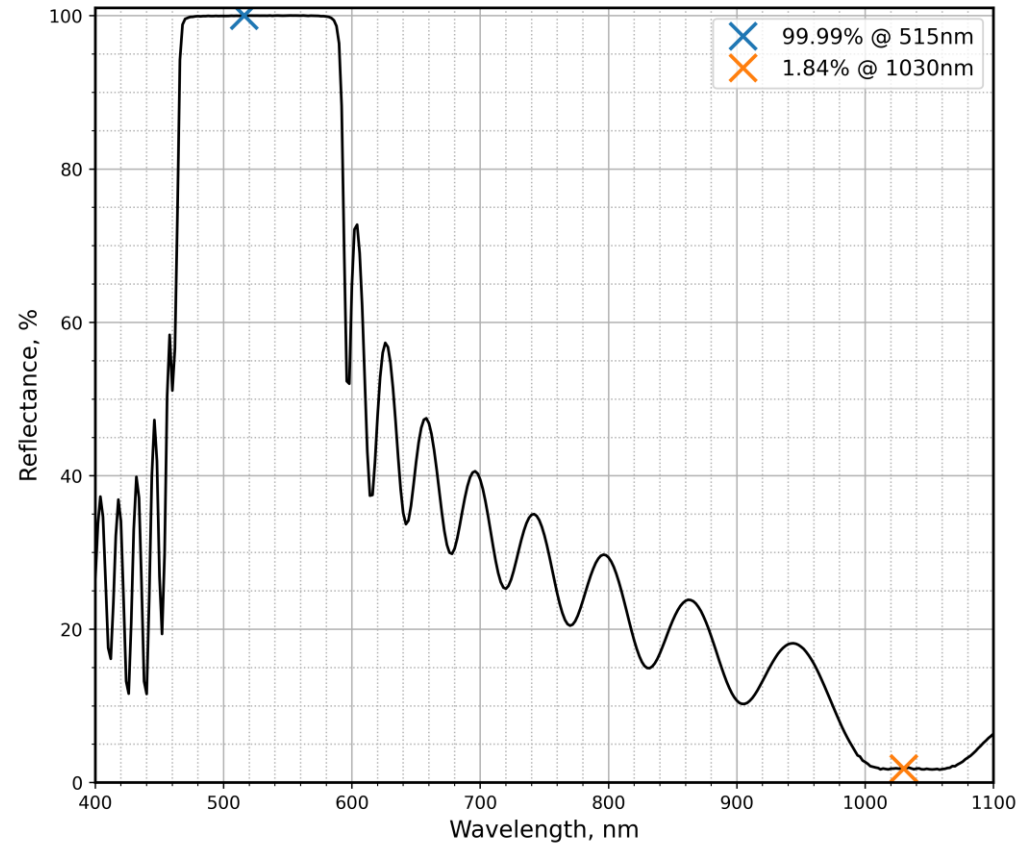
PO2870 Rp i45 (sample 2)

Fig. 4.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



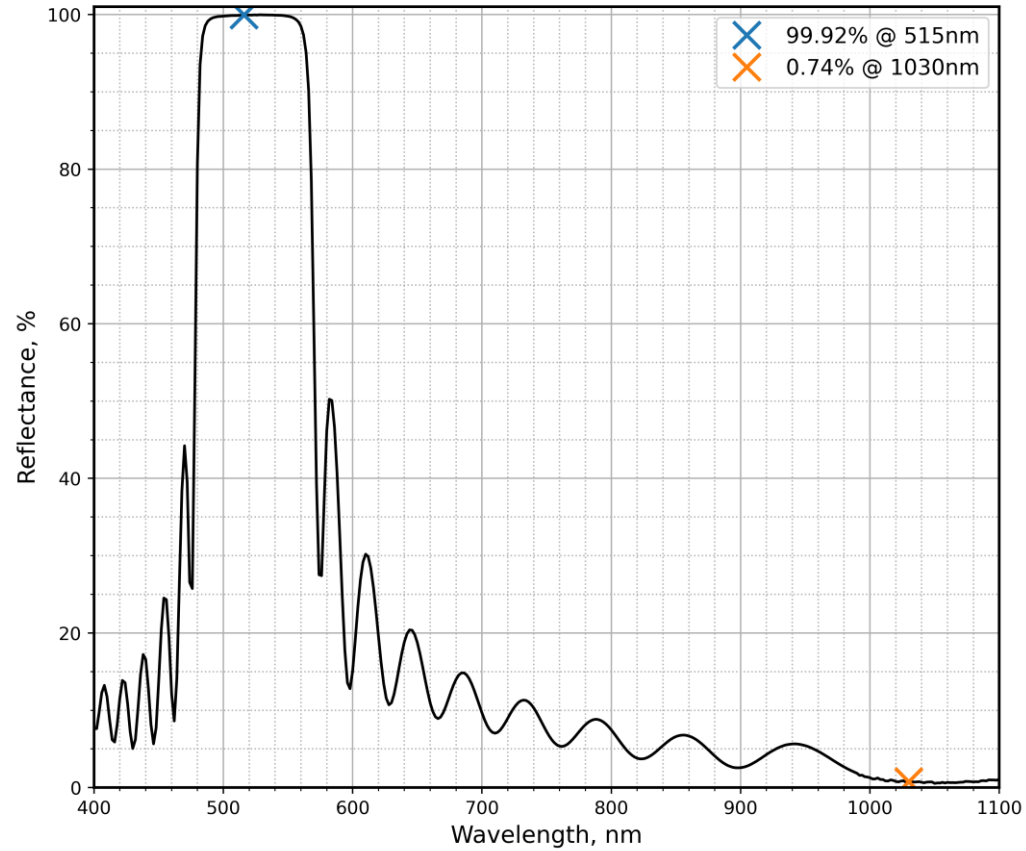
PO2870 Rs i45 (sample 3)

Fig. 5.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



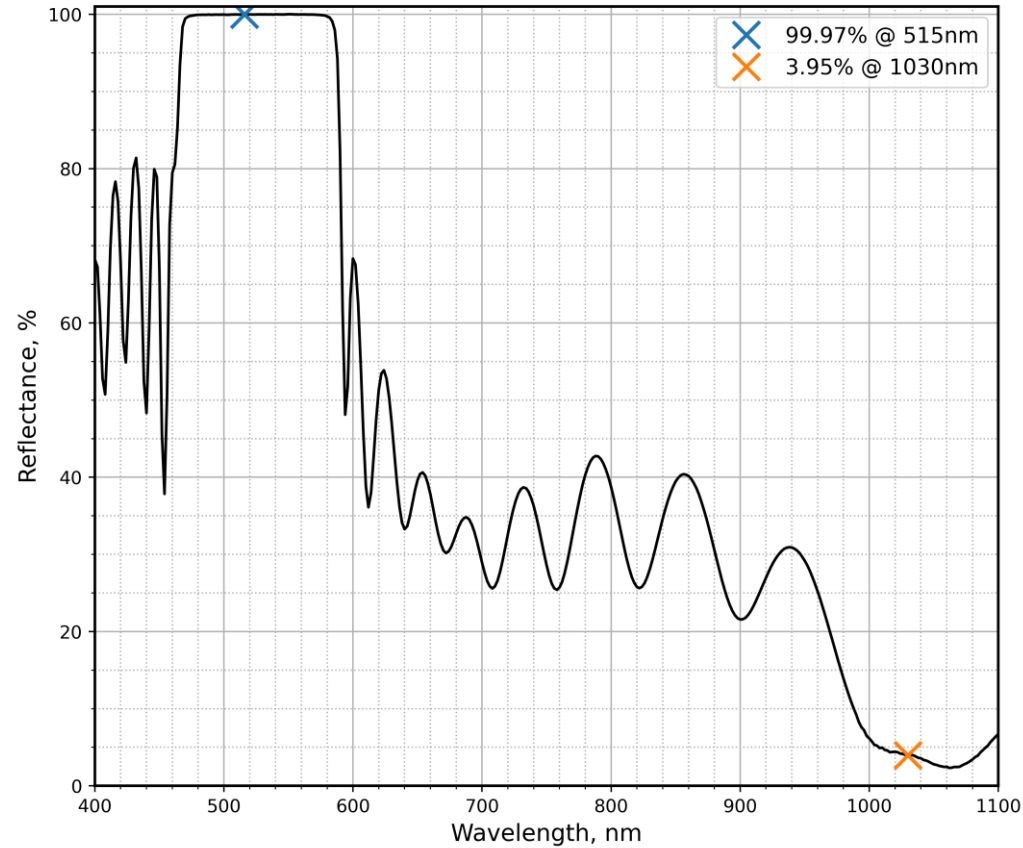
PO2870 Rp i45 (sample 3)

Fig. 6.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



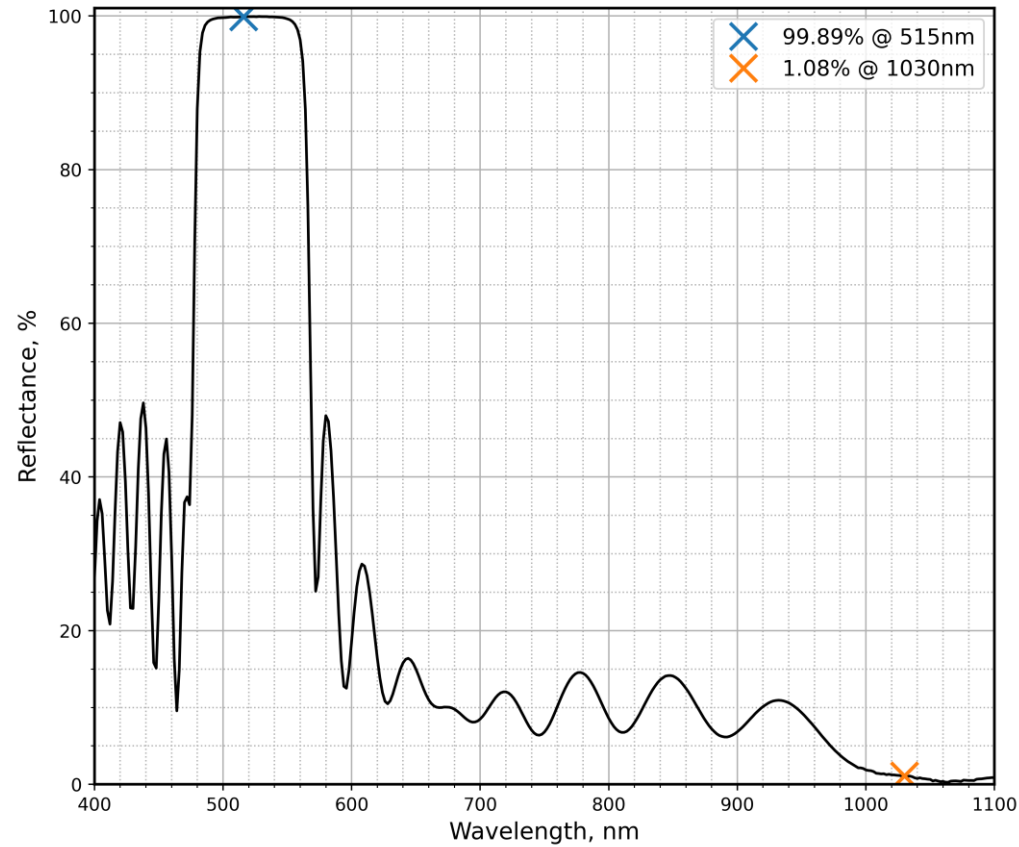
PO2870 Rs i45

Fig. 10.

SIDE MEASURED: S1+S2 (good component)

COMMENTS:

S1: HRsp>99.9% @ 515 nm+Rsp<2% @ 1030 nm, AOI=45 deg
S2: ARsp<0.6% @ 1030 nm, AOI=45 deg



PO2870 Rp i45

Fig. 11.

SIDE MEASURED: S1+S2 (good component)

COMMENTS: